

**Search Notes**

Application/Control No.

10/725,133

Examiner

W. Patty Chen

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	145-146	7/25/2007	WPC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
349	145-146	7/25/2007	WPC
see attached EAST search printout		7/25/2007	WPC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR